Docket No.: 282362US0PCT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION: Hisao IGARASHI, et al.

SERIAL NO.: 10/559,846 GAU: 2839

FILED: December 7, 2005 EXAMINER: HYEON, Hae M.

FOR: ANISOTROPIC CONDUCTIVE CONNECTOR AND WAFER INSPECTION DEVICE

| LETTER SUBMITTING NEW DRAWING SHEET   |   |
|---|---|
| COMMISSIONER FOR PATENTS<br>Alexandria, VA 22313                                  |   |
| SIR:  |   |
| Responsive to the below indicated communic herewith:                              | ation, the following drawing sheets are submitted |
| <ul><li>☐ Replacement Drawing Sheets</li><li>☐ Annotated Drawing Sheets</li></ul> | 1 New Drawing Sheets                              |
| Official Action dated October 18, 2007  |   |
| ☐ Notice of Allowance/Issue Fee dated   |   |
| Other dated   |   |
|   |   |

The changes and/or modifications made include the following:

The attached New Drawing Sheet for Fig. 19 is being submitted herewith in order to overcome the drawing objection stated on page 2 of the Official Action, dated October 18, 2007.

Respectfully Submitted,

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